

Notice of References Cited

Application/Control No.

09/675,548

Applicant(s)/Patent Under
Reexamination
PAAVOLA ET AL.

Examiner

John M. Villecco

Art Unit

2612

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,680,219	10-1997	Rydningen, Toni	356/635
	B	US-6,324,016	11-2001	Luster, Spencer D.	359/663
	C	US-4,123,169	10-1978	Merilainen et al.	356/639
	D	US-5,666,204	09-1997	Koskenohi, Kimmo	356/609
	E	US-6,100,986	08-2000	Rydningen, Toni	356/630
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 62137504 A	06-1987	Japan	OKAZAKI et al.	G01B 11/04
	O	JP 08304032 A	11-1996	Japan	HONMA et al.	G01B 11/06
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Kane, J.; "Telecentric Lenses: What You Need to Know?"; Computer Optics Inc.; 1999-2002; < http://www.computeroptics.com/telecentric.html >
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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